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Application No.	Applicant(s)
10/020,628	VISSER ET AL.
Examiner	Art Unit
Mohamed Charioui	2857

Mohamed Charioui

SEARCHED				
Class	Subclass	Date	Examiner	
702	58, 59, 64, 117, 118, 119	11/16/2004	МС	
702	123, 124	11/16/2004	МС	
702	126, 185	11/16/2004	МС	
702	189	11/16/2004	МС	
324	72.5	11/16/2004	мс	
324	527, 537	11/16/2004	МС	
324	538, 763	11/16/2004	МС	
324	765	11/16/2004	МС	
714	734	11/16/2004	мс	
716	4	11/16/2004	МС	

INTERFERENCE SEARCHED				
Class	Subclass	Date	Examiner	
	1			

SEARCH NOT (INCLUDING SEARCH		)
	DATE	EXMR
Consulted with Hal Wachsman	11/16/2004	МС
East: (error near message) with (pin or pins)	11/17/2004	мс
East: (((pin or pins) near5 voltage) with disconnect\$)	11/17/2004	мс
East: ((apply or applying or applied) near voltage near (pin or pins)) with "integrated circuits"	11/17/2004	мс
East: ((pin or pins) near10 connect\$ near10 (open or disconnect\$)) with voltage	11/17/2004	МС
East: (open near5 detect\$) with (pin or pins)	11/17/2004	MC
East: connection with (pin or pins) with voltage with resistor	11/17/2004	MC